

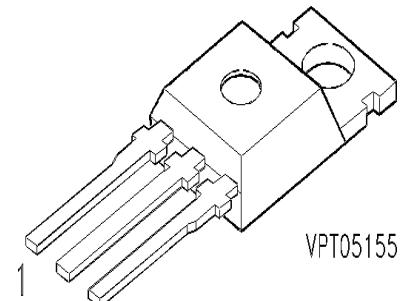
Smart Lowside Power Switch

Features

- Logic Level Input
- Input Protection (ESD)
- Temperature limitation adjustable by input voltage
- Overload protection
- Short circuit protection
- Overvoltage protection
- Current limitation
- Analog driving possible

Product Summary

Drain source voltage	V_{DS}	42	V
On-state resistance	$R_{DS(on)}$	18	$\text{m}\Omega$
Nominal load current	$I_{D(\text{ISO})}$	19	A
Clamping energy	E_{AS}	2	J



Application

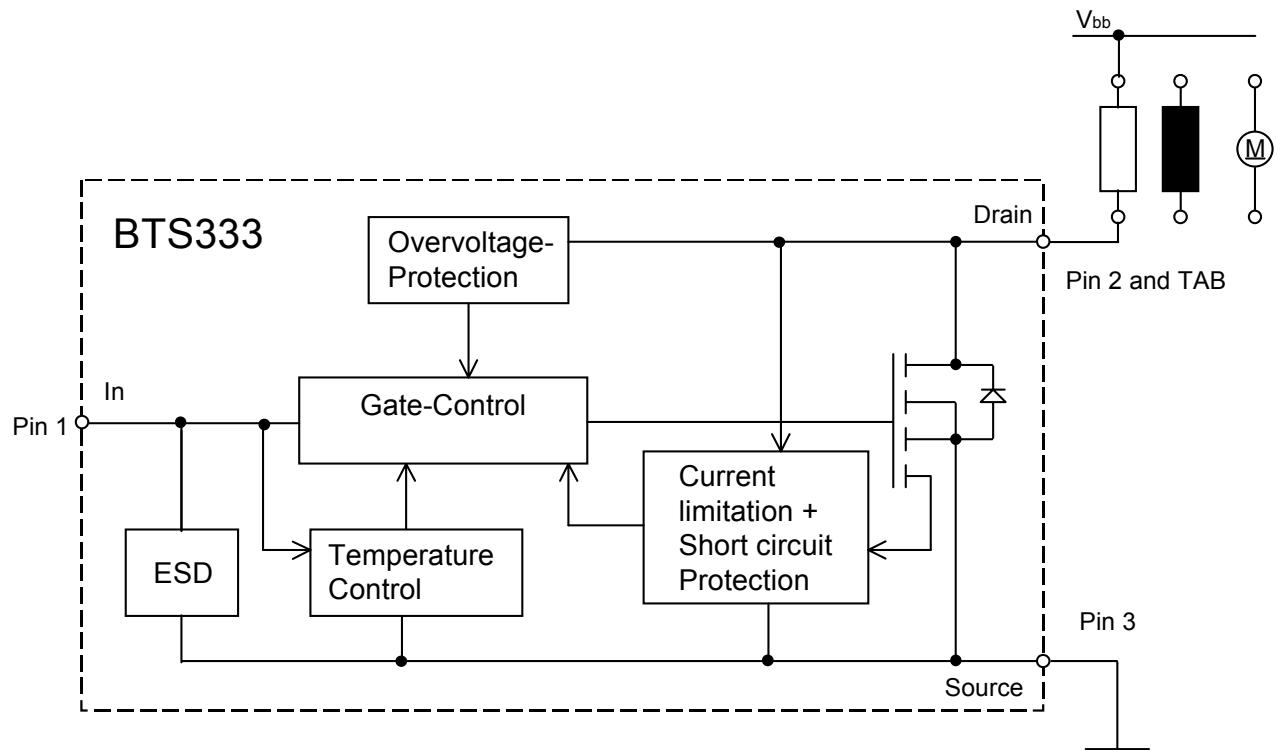
- All kinds of resistive, inductive and capacitive loads in switching or linear applications
- µC compatible power switch for 12 V and 24 V DC applications
- Replaces electromechanical relays and discrete circuits

General Description

N channel vertical power FET in Smart SIPMOS® technology. Fully protected by embedded protection functions.

Pin	Symbol		Function
1	IN		Input
2	DRAIN		Output to the load
3	SOURCE		Ground
TAB	DRAIN		Output to the load

Block Diagram



Maximum Ratings at $T_j = 25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Value	Unit
Drain source voltage	V_{DS}	42	V
Drain source voltage for full SCP SCP Type I, $V_{IN} \leq 10\text{V}$ SCP Type II, $V_{IN} \leq 7\text{V}$	$V_{DS(\text{SC})}$	36 24	
Continuous input current $-0.2\text{V} \leq V_{IN} \leq 10\text{V}$ $V_{IN} < -0.2\text{V}$ or $V_{IN} > 10\text{V}$	I_{IN}	no limit $ I_{IN} \leq 4$	mA
Operating temperature ¹⁾	T_j	-40 ... +175	°C
Storage temperature	T_{stg}	-55 ... +150	
Power dissipation $T_C = 85^\circ\text{C}$	P_{tot}	100	W
Unclamped single pulse inductive energy ²⁾ $I_D = 19\text{ A}$, $T_j = 25^\circ\text{C}$, $V_{bb} = 12\text{ V}$ $I_D = 19\text{ A}$, $T_j = 150^\circ\text{C}$, $V_{bb} = 12\text{ V}$	E_{AS}	2 0.5	J
Load dump protection $V_{LoadDump}^{3)} = V_A + V_S$ $V_{IN} = 0$ and 10 V , $t_d = 400\text{ ms}$, $R_I = 2\Omega$, $R_L = 1\Omega$, $V_A = 13.5\text{ V}$	V_{LD}	55	V
Electrostatic discharge voltage (Human Body Model) according to MIL STD 883D, method 3015.7 and EOS/ESD assn. standard S5.1 - 1993	V_{ESD}	2	kV
DIN humidity category, DIN 40 040		E	
IEC climatic category; DIN IEC 68-1		40/150/56	

Thermal resistance

junction - case:	R_{thJC}	0.8	K/W
junction - case:	R_{thJA}	75	

¹Temperatures above 175°C will reduce lifetime of the device

²Not tested, specified by design.

³ $V_{Loaddump}$ is setup without the DUT connected to the generator per ISO 7637-1 and DIN 408

Electrical Characteristics

Parameter at $T_j = 25^\circ\text{C}$, unless otherwise specified	Symbol	Values			Unit
		min.	typ.	max.	
Characteristics					
Drain source clamp voltage $T_j = -40 \dots +150^\circ\text{C}, I_D = 10 \text{ mA}$	$V_{DS(AZ)}$	42	-	55	V
Off-state drain current $V_{DS} = 32 \text{ V}, T_j = -40 \dots +85^\circ\text{C}, V_{IN} = 0 \text{ V}$ $V_{DS} = 32 \text{ V}, T_j = -40 \dots +150^\circ\text{C}, V_{IN} = 0 \text{ V}$	I_{DSS}	-	1	5	μA
-	-	-	1	20	
Gate threshold voltage, $V_{GS} = V_{DS}$ $I_D = 1.9 \text{ mA}, T_j = -40^\circ\text{C}$ $I_D = 1.9 \text{ mA}, T_j = 25^\circ\text{C}$	$V_{GS(\text{th})}$	-	-	2.4	V
-	-	1.3	1.7	2.2	
On state input current (temp. limit. inactiv) $V_{IN} = 10 \text{ V}$ $V_{IN} = 5 \text{ V}$	$I_{IN(\text{on})}$	-	200	300	μA
-	-	-	10	30	
On-state resistance $V_{IN} = 5 \text{ V}, I_D = 19 \text{ A}, T_j = 25^\circ\text{C}$ $V_{IN} = 5 \text{ V}, I_D = 19 \text{ A}, T_j = 150^\circ\text{C}$	$R_{DS(\text{on})}$	-	18	23	$\text{m}\Omega$
-	-	-	29	46	
On-state resistance $V_{IN} = 10 \text{ V}, I_D = 19 \text{ A}, T_j = 25^\circ\text{C}$ $V_{IN} = 10 \text{ V}, I_D = 19 \text{ A}, T_j = 150^\circ\text{C}$	$R_{DS(\text{on})}$	-	14	18	
-	-	-	26	36	
Nominal load current $V_{IN} = 10 \text{ V}, T_j < 150^\circ\text{C}, T_A = 85^\circ\text{C}$	$I_{D(\text{ISO})}$	19	-	-	A
Continuous drain current ¹⁾ $T_C = 120^\circ\text{C}, V_{IN} = 10 \text{ V}$	I_D	25	-	-	
Current limit (active if $V_{DS} > 2.5 \text{ V}$) ²⁾ $V_{IN} = 10 \text{ V}, V_{DS} = 12 \text{ V}, t_m = 300 \text{ }\mu\text{s}$	$I_{D(\text{lim})}$	35	50	65	

¹if not limited by current limitation

²Device switched on into existing short circuit (see diagram Determination of $I_{D(\text{lim})}$). If the device is in on condition and a short circuit occurs, these values might be exceeded for max. 50 μs .

Electrical Characteristics

Parameter at $T_j = 25^\circ\text{C}$, unless otherwise specified	Symbol	Values			Unit
		min.	typ.	max.	

Dynamic Characteristics

Turn-on time V_{IN} to 90% I_D : $R_L = 2 \Omega$, $V_{IN} = 0$ to 10 V, $V_{bb} = 12$ V	t_{on}	-	140	250	μs
Turn-off time V_{IN} to 10% I_D : $R_L = 2 \Omega$, $V_{IN} = 10$ to 0 V, $V_{bb} = 12$ V	t_{off}	-	250	350	
Slew rate on 70 to 50% V_{bb} : $R_L = 2 \Omega$, $V_{IN} = 0$ to 10 V, $V_{bb} = 12$ V	$-dV_{DS}/dt_{on}$	-	0.1	1	V/μs
Slew rate off 50 to 70% V_{bb} : $R_L = 2 \Omega$, $V_{IN} = 10$ to 0 V, $V_{bb} = 12$ V	dV_{DS}/dt_{off}	-	0.2	1	

Protection Functions

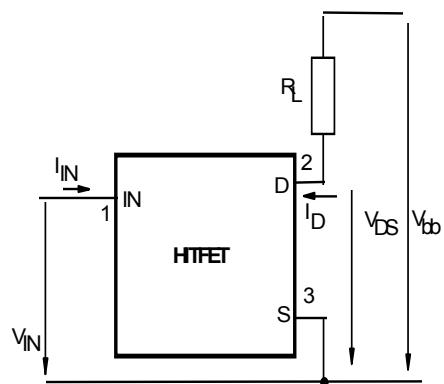
Input current protection mode $V_{IN} = 5$ V $V_{IN} = 10$ V	$I_{IN(Prot)}$	-	--	300	μA
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Inverse Diode

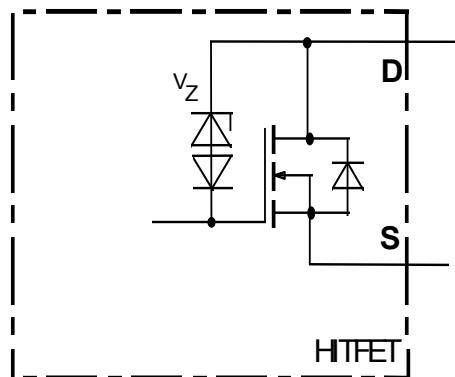
Inverse diode forward voltage $t_m = 250$ μs, $V_{IN} = 0$ V, $-I_D = 5*19$ A, $t_P = 300$ μs	V_{SD}	-	1.0	-	V
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Block diagram

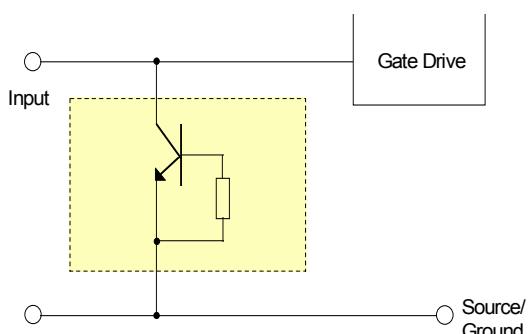
Terms



Inductive and overvoltage output clamp



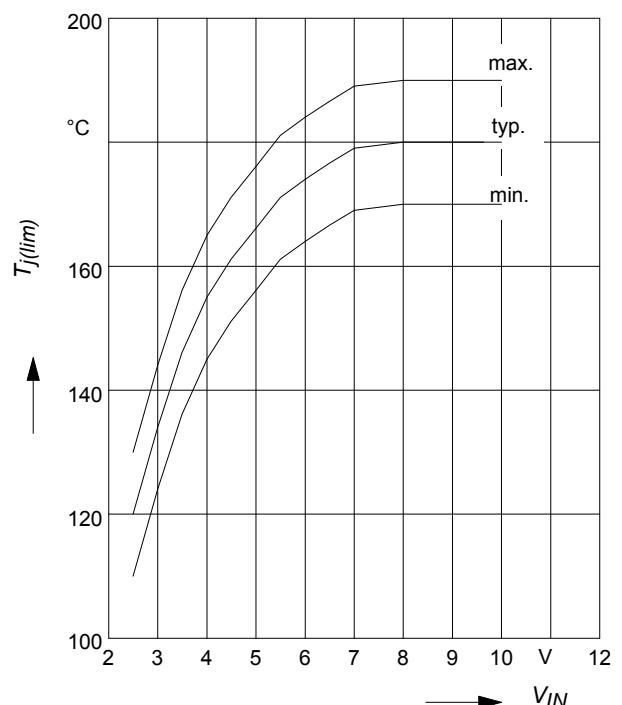
Input circuit (ESD protection)



Input is not designed for DC current > 4 mA

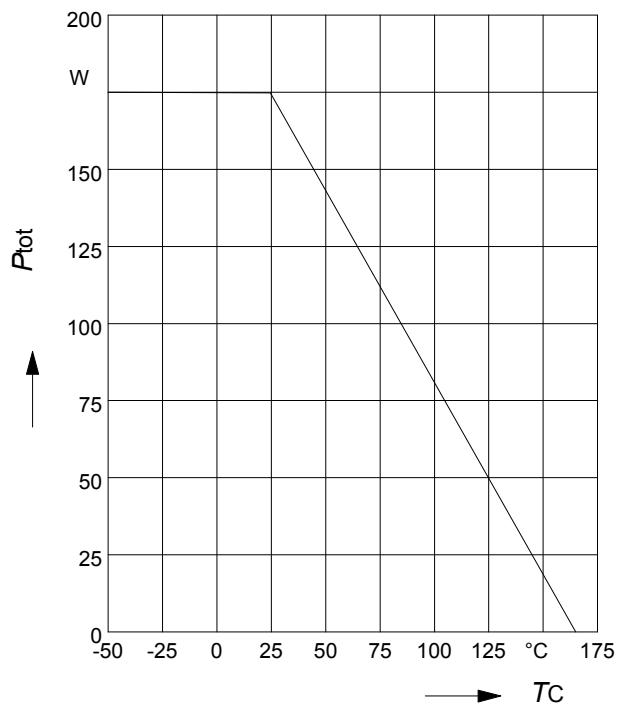
Temperature limitation

$T_{j(\text{lim})} = f(V_{IN})$; $V_{DS} = 6V$; $I_D = 10A$;
 $t_m = 150 \dots 400 \mu\text{s}$ (guaranteed by charact.)



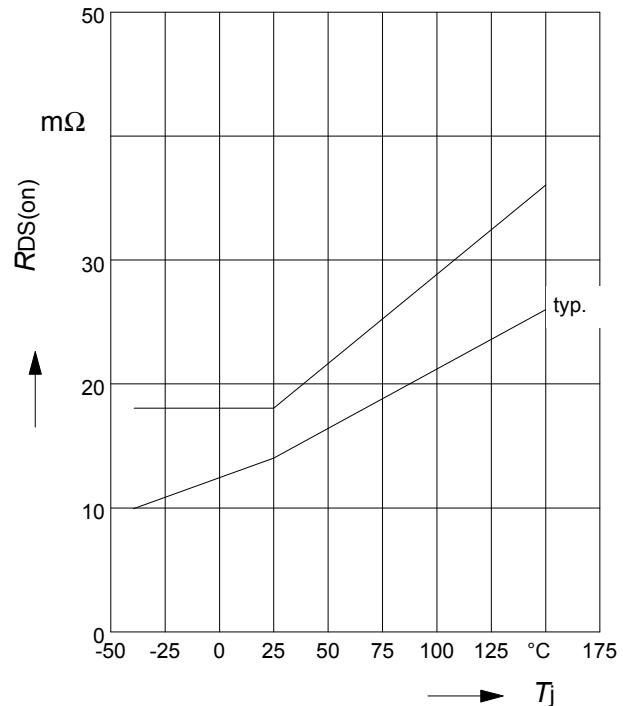
1 Maximum allowable power dissipation

$$P_{\text{tot}} = f(T_C)$$



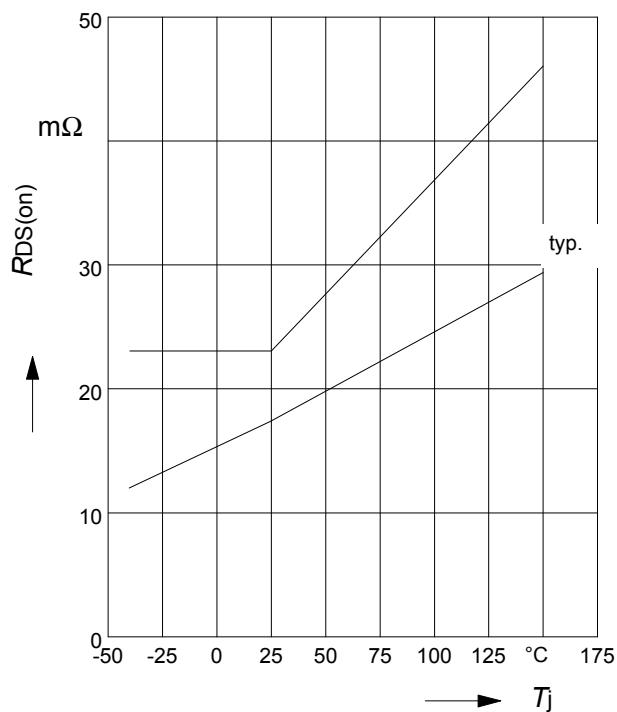
2 On-state resistance

$$R_{\text{ON}} = f(T_j); I_D = 19\text{A}; V_{\text{IN}} = 10\text{V}$$



3 On-state resistance

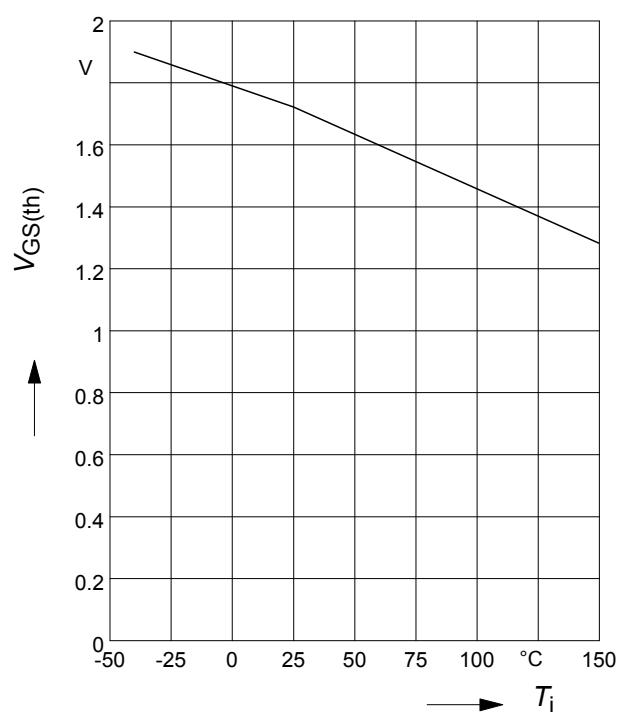
$$R_{\text{ON}} = f(T_j); I_D = 19\text{A}; V_{\text{IN}} = 5\text{V}$$



4 Typ. input threshold voltage

$$V_{\text{GS}(\text{th})} = f(T_j); I_D = 1.9 \text{ mA}; V_{\text{DS}} = 12\text{V}$$

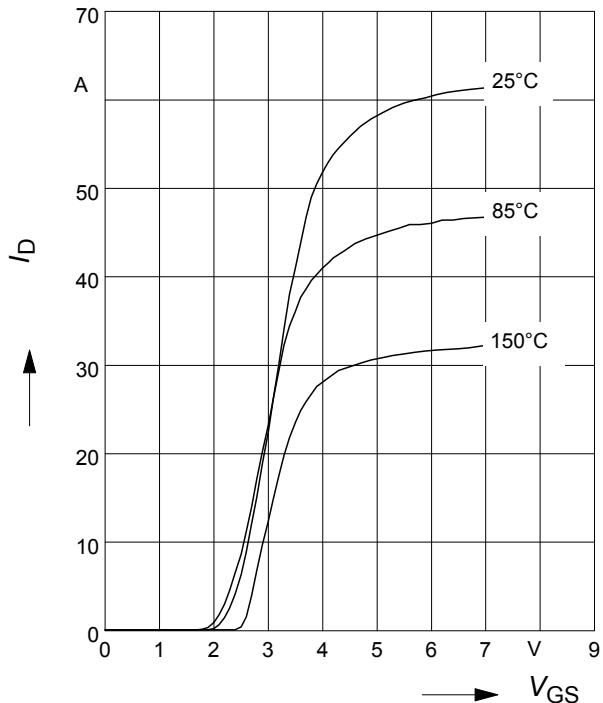
(guaranteed by characterization)



5 Typ. transfer characteristics

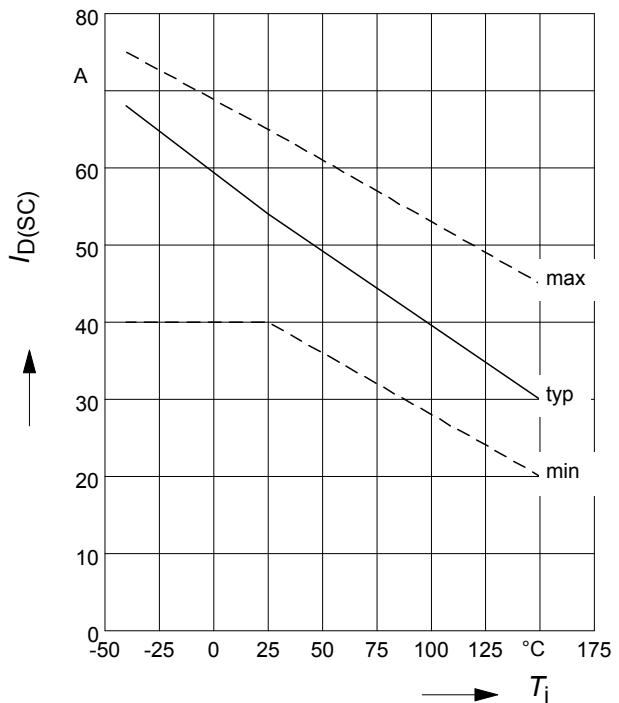
$I_D = f(V_{IN})$; $V_{DS} = 12V$; Param. = T_{Jstart}

(guaranteed by characterization)



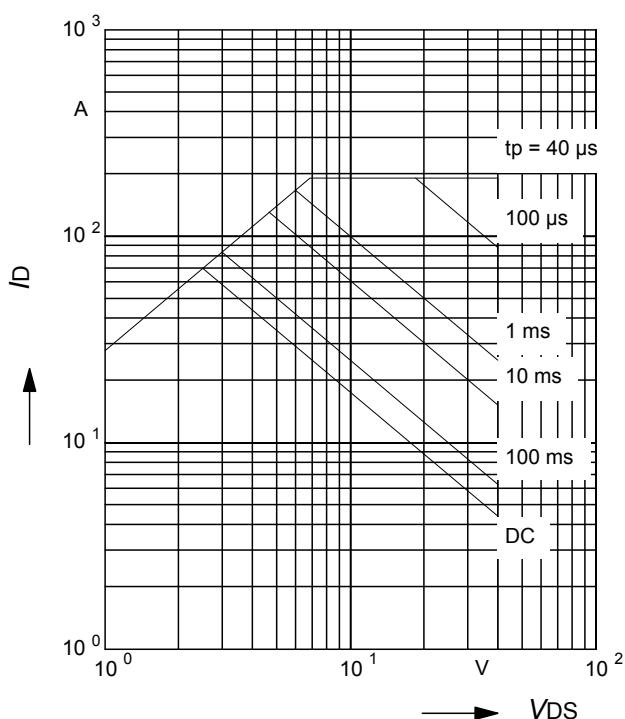
6 Typ. short circuit current

$I_{D(\text{lim})} = f(T_j)$; $V_{DS} = 12V$; $V_{IN} = 10V$



7 Safe Operating Area

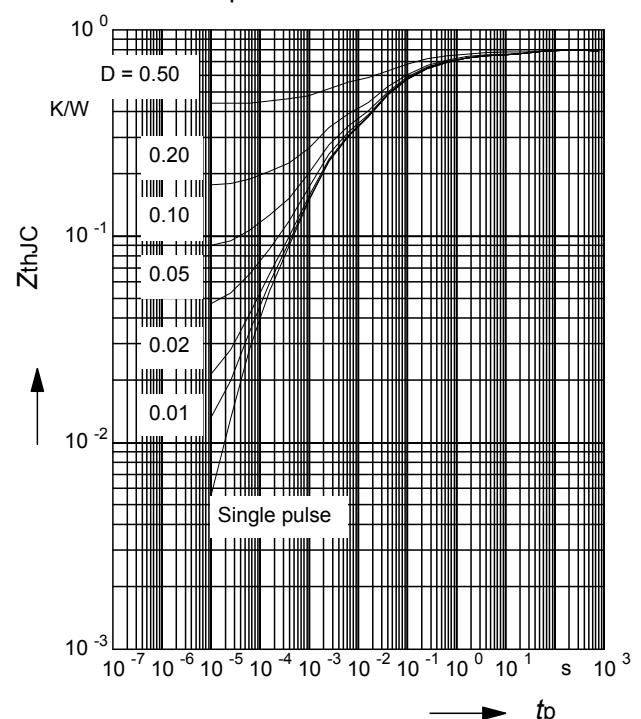
$I_D(\text{SC}) = f(V_{DS})$; $T_j = 25^\circ\text{C}$

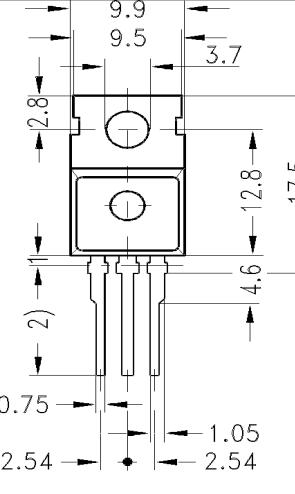
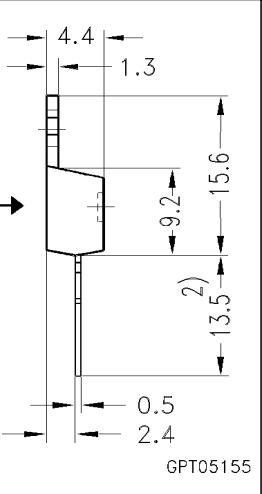


8 Typ. transient thermal impedance

$Z_{\text{thJC}} = f(t_p)$

Parameter: $D = t_p/T$



Package	Ordering Code
P-TO220-3-1	Q67060 S6506
 1) punch direction, burr max. 0.04 2) dip tinning 3) max. 14.5 by dip tinning press burr max. 0.05	 GPT05155

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